

Application/Control No.	Applicant(s)/Patent under Reexamination	r
09/724,296	DOETSCH ET AL.	
Examiner	Art Unit	
Malgorzata A. Walicka	1652	

	SEARCHED				
Class	Subclass	Date	Examiner		
435	195	01/24/02	chil		
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435	6				
536	23.2	$ \hspace{.05cm} $	\downarrow		
435	196	04/19/05	M		
	18	↓	\downarrow		
435	91.1	04/20/09	M		
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INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
SEQ IDNO	2,4,36, 37,38,39	01/20/02	des				
SEQUAL:2	AA 230-82 8	09/18/02					
	and	04/19/05					
435/19	6;18;	04/19/05					
435/196;18;		04/20/05	¬				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
SEQ 1D NO: 2,4,36, 37,38,39 and 6 AA 230-828 of SEQUINO: 2	01/20/02 09/18/02 04/19/05	dul dw dul		
Appl. 09/327, 984 (parent Patent 6, 368, 594	01/20/02 04/19/05	dh hv		
Inventor name	01/20/02 04/19/05	del del		
Ibs	09/18/02	M		
Provisionals	01/25/02	der		
60/088,521 60/134 ,7, 52	09/18/02			
(aplus author Yasui uv damage endonnde ase; in record	12/29/03	M		